

# **Capacitive-Division Traveling-Wave Amplifier with 340 GHz Gain-Bandwidth Product**

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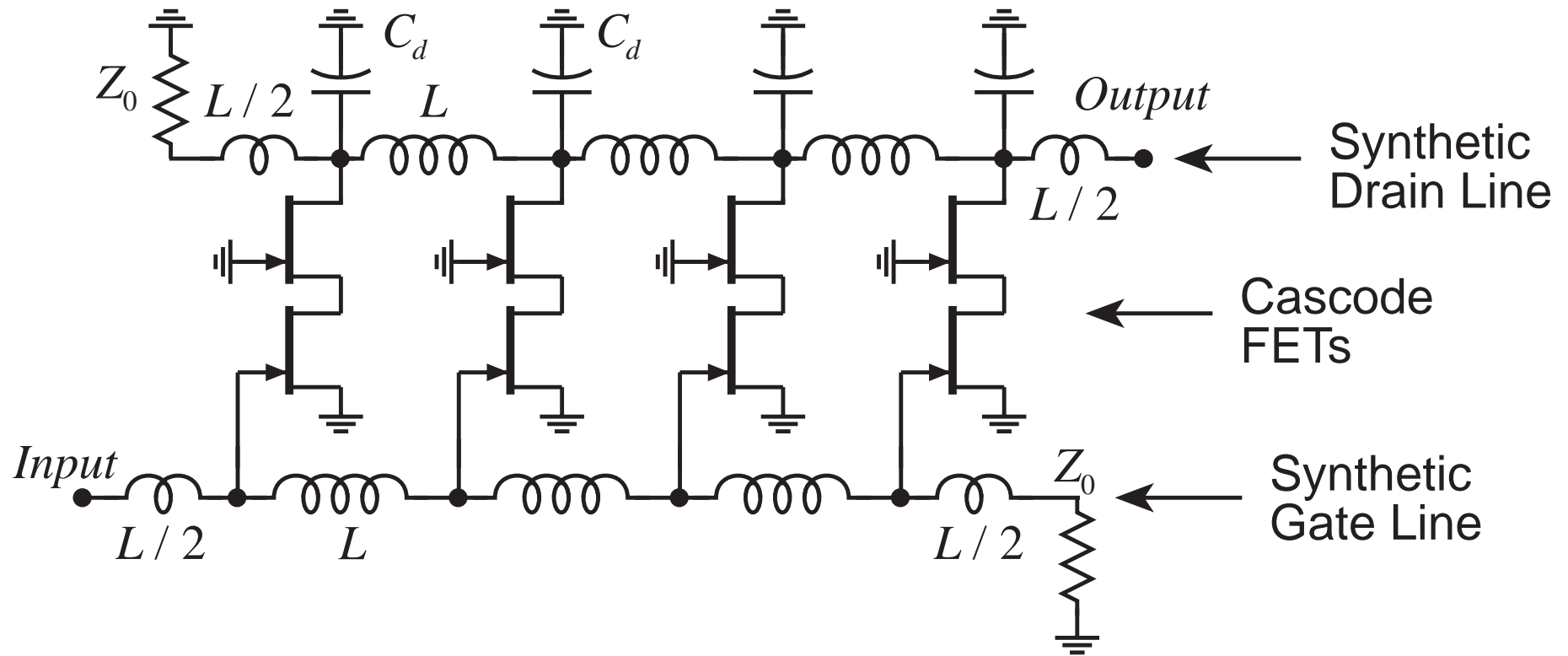
## Support:

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# Capacitive-Division Traveling-Wave Amplifier

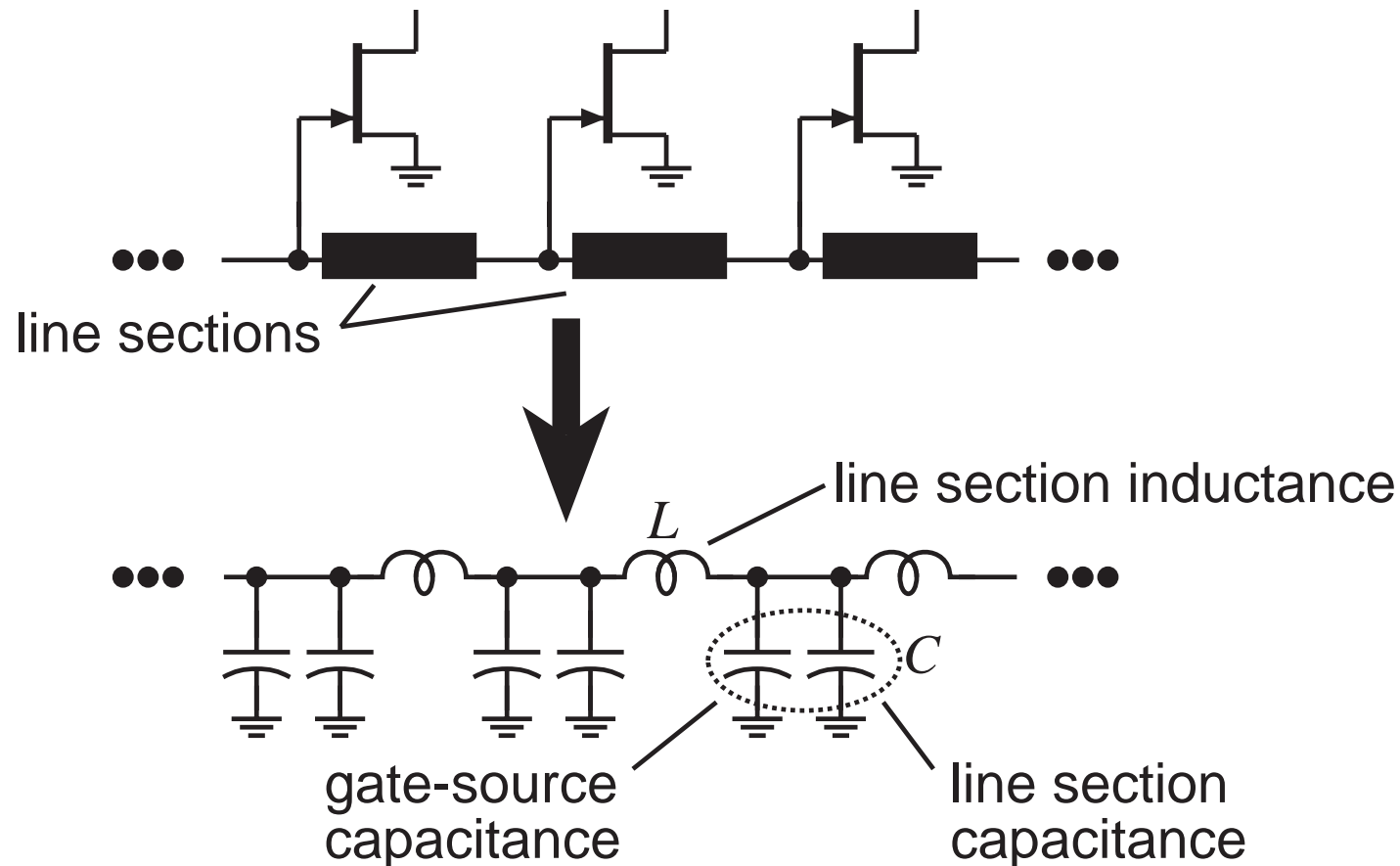
- Traveling-wave (distributed) amplifier :  
standard broadband IC
- Capacitive division TWA:  
Ayasli, 1988  
broadband power
- Capacitive division TWA:  
significantly larger gain-bandwidth product
- This work: InGaAs/InAlAs HEMT CDTWAs
- Result: 11 dB gain, 96 GHz bandwidth
- Record 340 GHz gain-bandwidth product

# Principles of Traveling-Wave Amplifiers



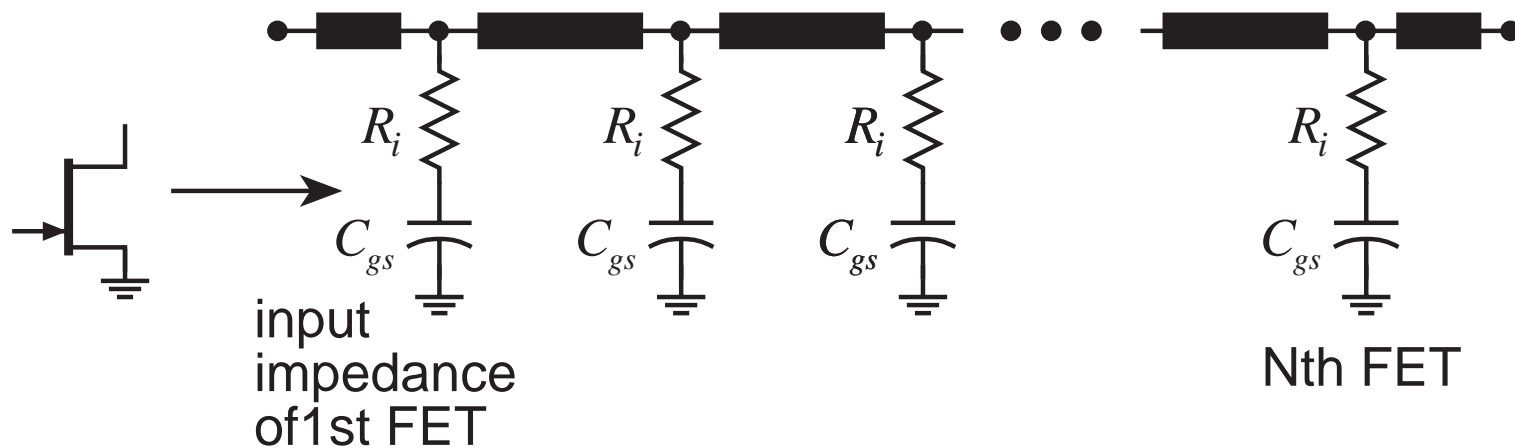
- Broadband circuit.
- FET input / output capacitances absorbed into synthetic transmission lines.
- Gain-bandwidth limited by line losses resulting from FET resistive parasitics.

# Synthetic Transmission Lines in TWAs



- Characteristic impedance:  $Z_0 = \sqrt{L/C}$
- Cutoff frequency:  $f_{cutoff} = 1/\pi\sqrt{LC}$

# TWA Bandwidth Limited by Gate-Line Losses

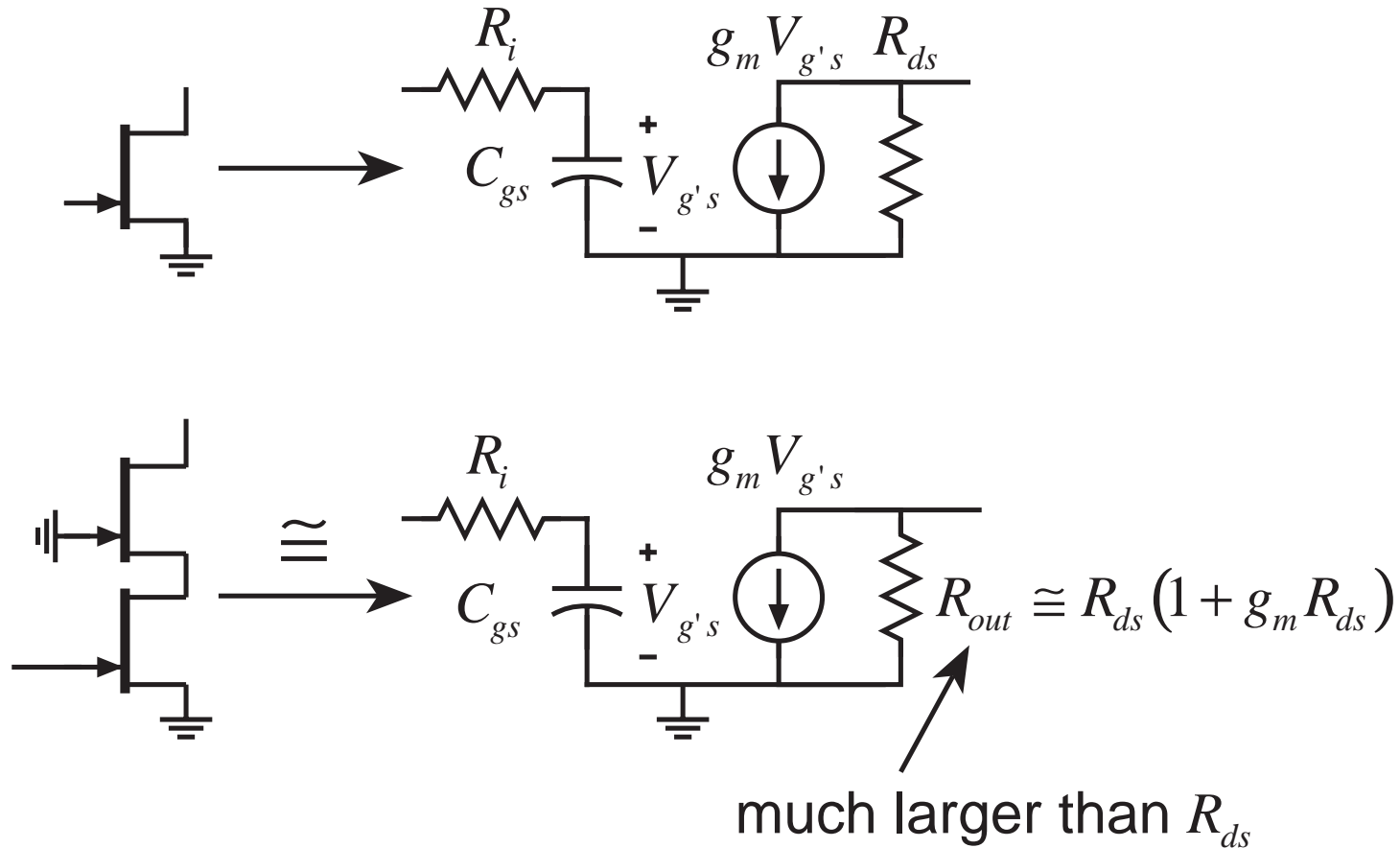


- FET input resistance  $R_i$  causes gate line attenuation
- transistors far from input not driven at high frequency
- this limits gain-bandwidth (Ayasli, 1982):

$$|S_{21}| f_{high}^2 \leq \frac{f_{\tau}}{4\pi R_i C_{gs}}$$

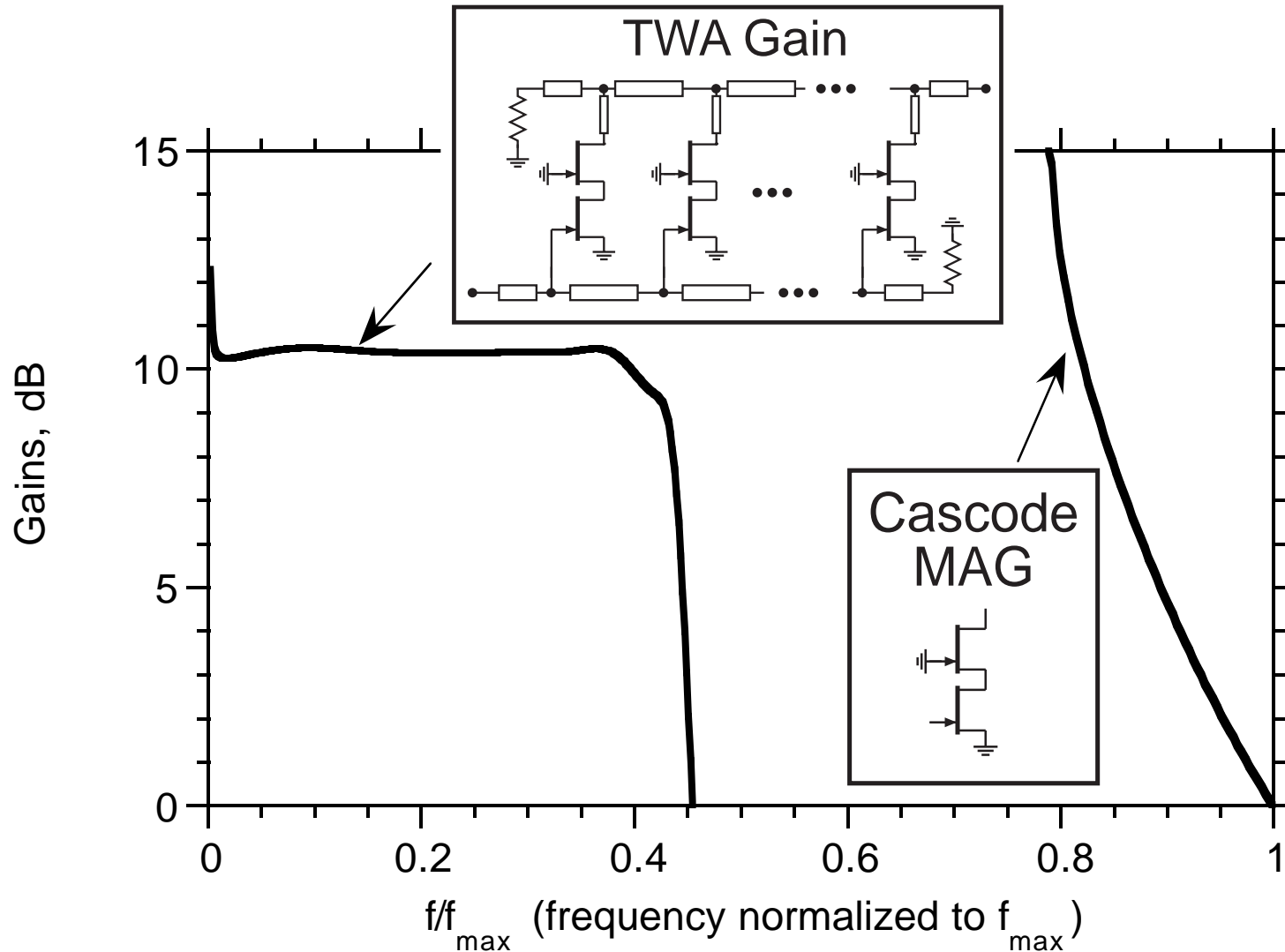
...if drain line losses are small (cascode TWA)

# Cascode Cell: Negligible Drain-Line Losses



- Cascode cell:
  - very large output resistance
  - drain line losses nearly eliminated
  - model valid for frequencies significantly below  $f_{max}$*

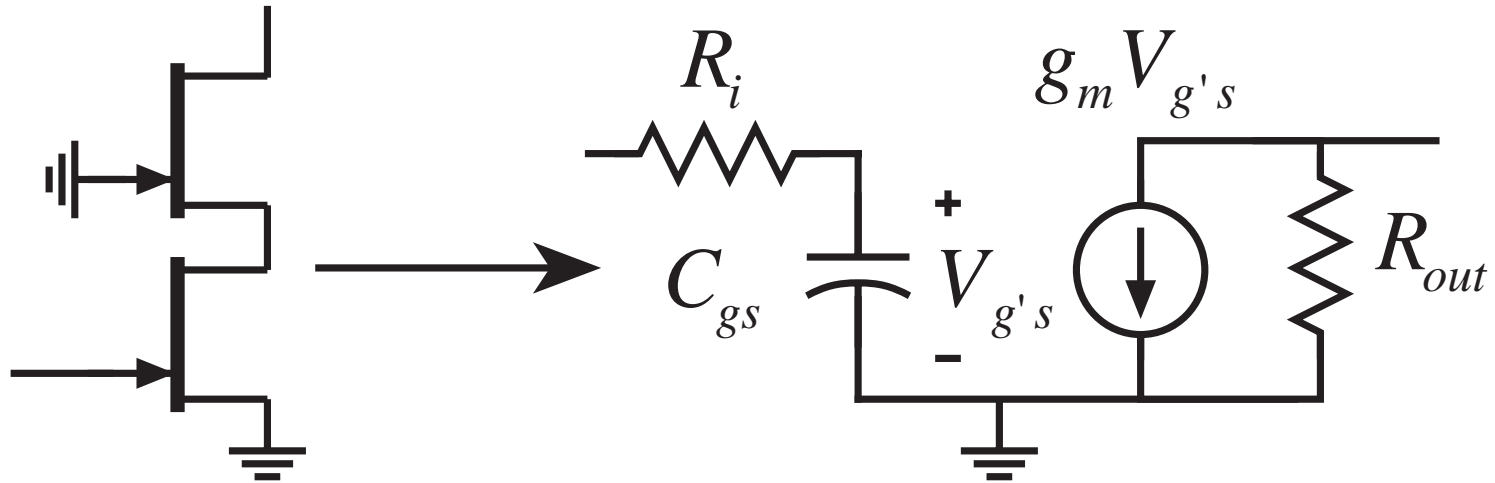
# Normal cascode TWAs are not optimal designs



- Gain-bandwidth is well below MAG of cascode cell because  $50\Omega$  load much smaller than cascode  $R_{out}$

# Examine the Gain-Bandwidth Limit:

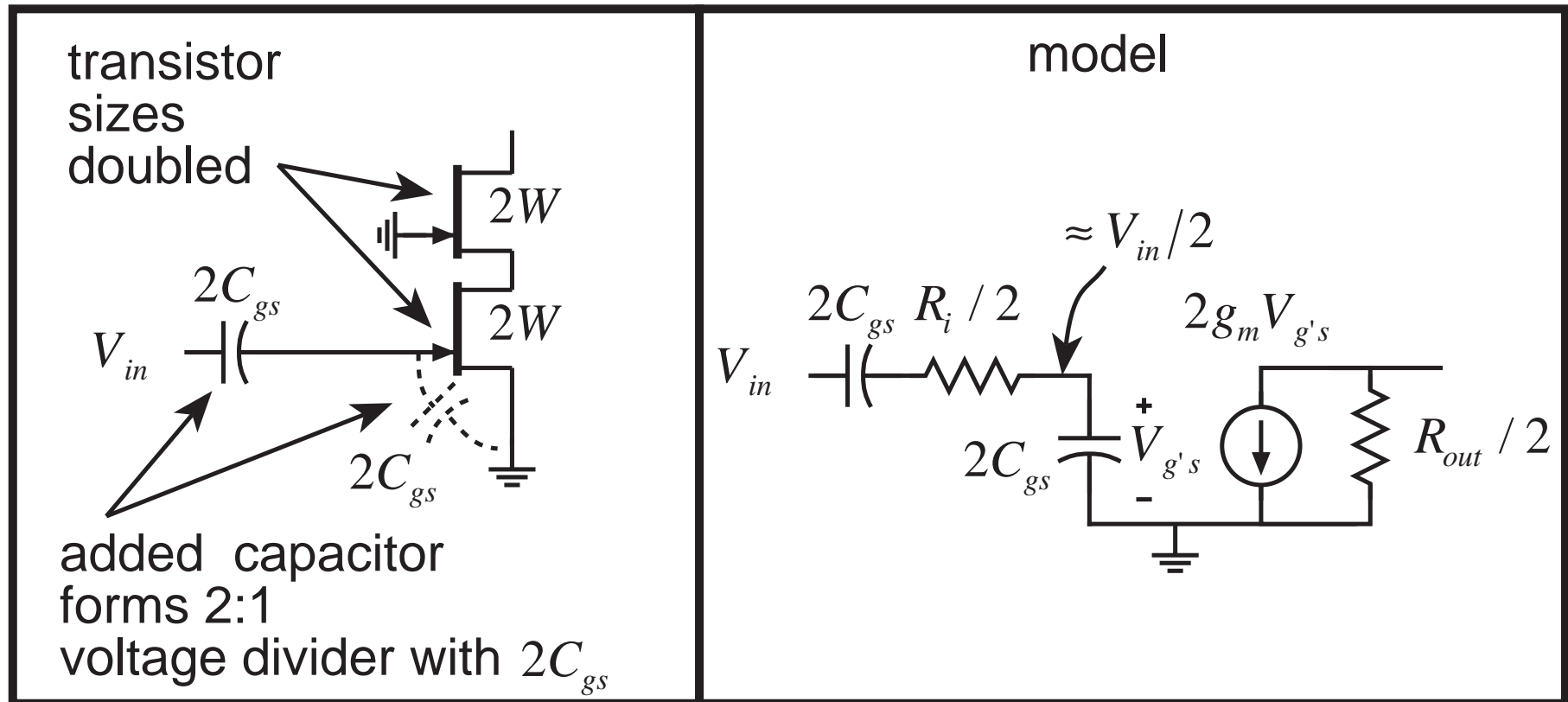
$$|S_{21}| f_{high}^2 \leq \frac{f_{\tau}}{4\pi R_i C_{gs}}$$



- Decreasing  $R_i$  increases gain-bandwidth...
- How can we decrease input resistance  $R_i$ ?

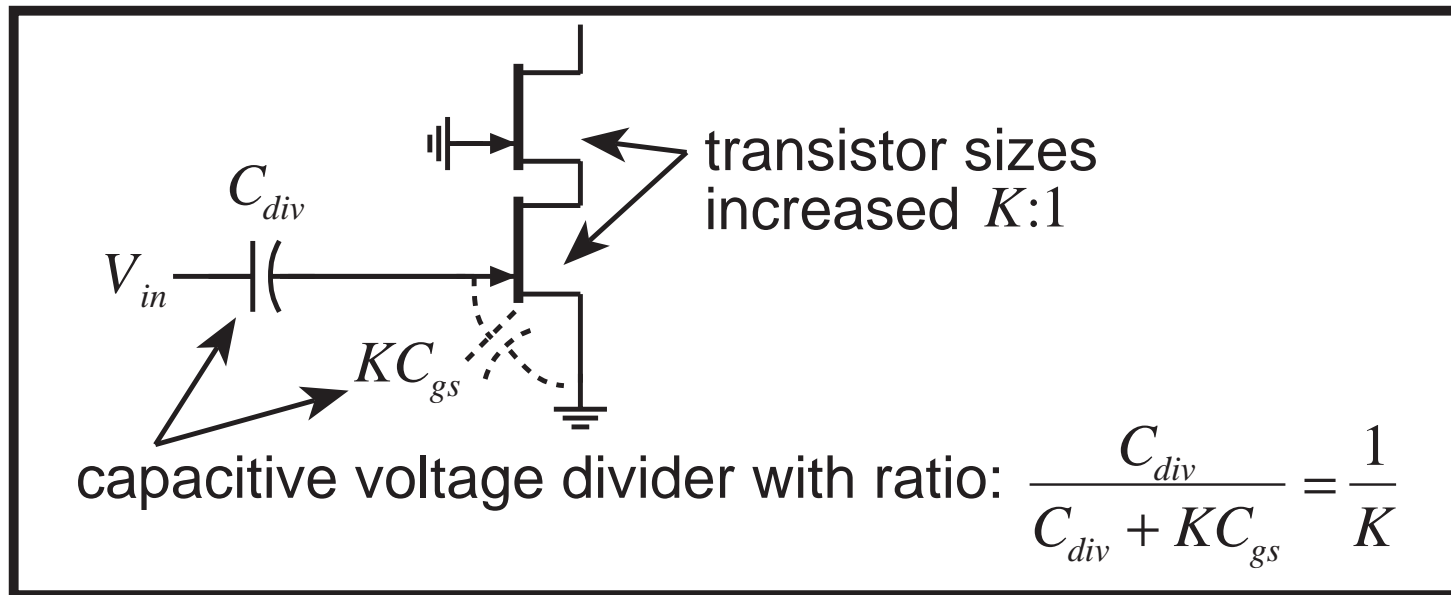


# Capacitive Division Reduces Input Resistance



- same input capacitance,
- same net transconductance
- input & output resistances reduced 2:1
- 2:1 division shown; higher ratios possible

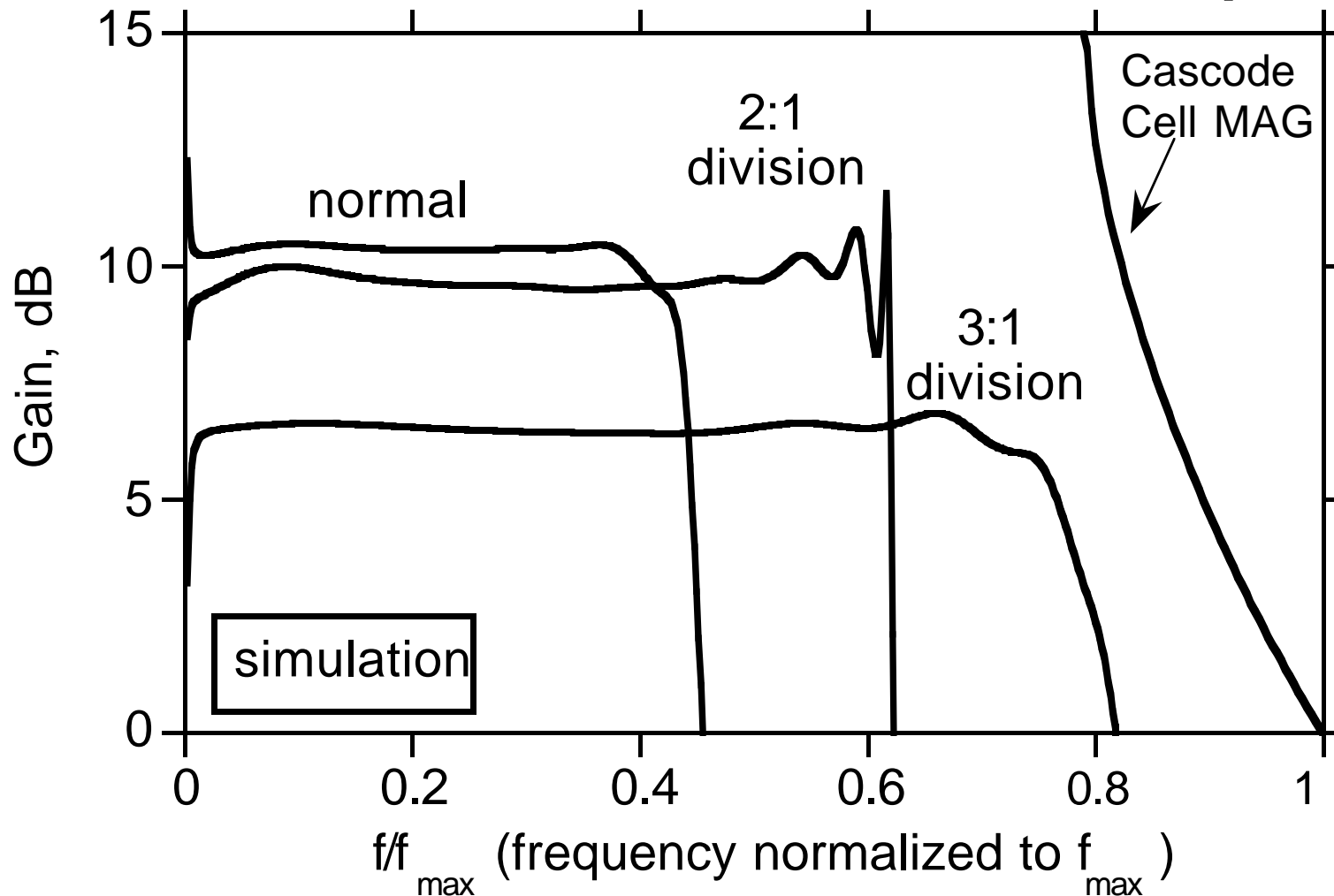
# Capacitive Division Increases TWA Gain-Bandwidth



- input & output resistances reduced  $K:1$
- gate line losses reduced  $K:1$
- $K:1$  more stages can be used: more gain
- at any design bandwidth, gain improved  $K:1$

$$\|S_{21}\| f_{high}^2 \leq K \cdot \left( \frac{f_{\tau}}{4\pi R_i C_{gs}} \right)$$

# How Much Can Gain-Bandwidth Be Improved?



Large division ratios:

- drain losses now significant, limits gain-bandwidth
- gain-bandwidth approaches MAG limit— *optimal circuit*
- big FETs, difficult layout

# Implementation / Design Features

Hughes Research Laboratories low noise HEMT

- InAlAs / InGaAs / InP HEMT
- 0.15  $\mu\text{m}$  gate length
- $f_t = 160 \text{ GHz}$ ,  $f_{\text{max}} = 260 \text{ GHz}$

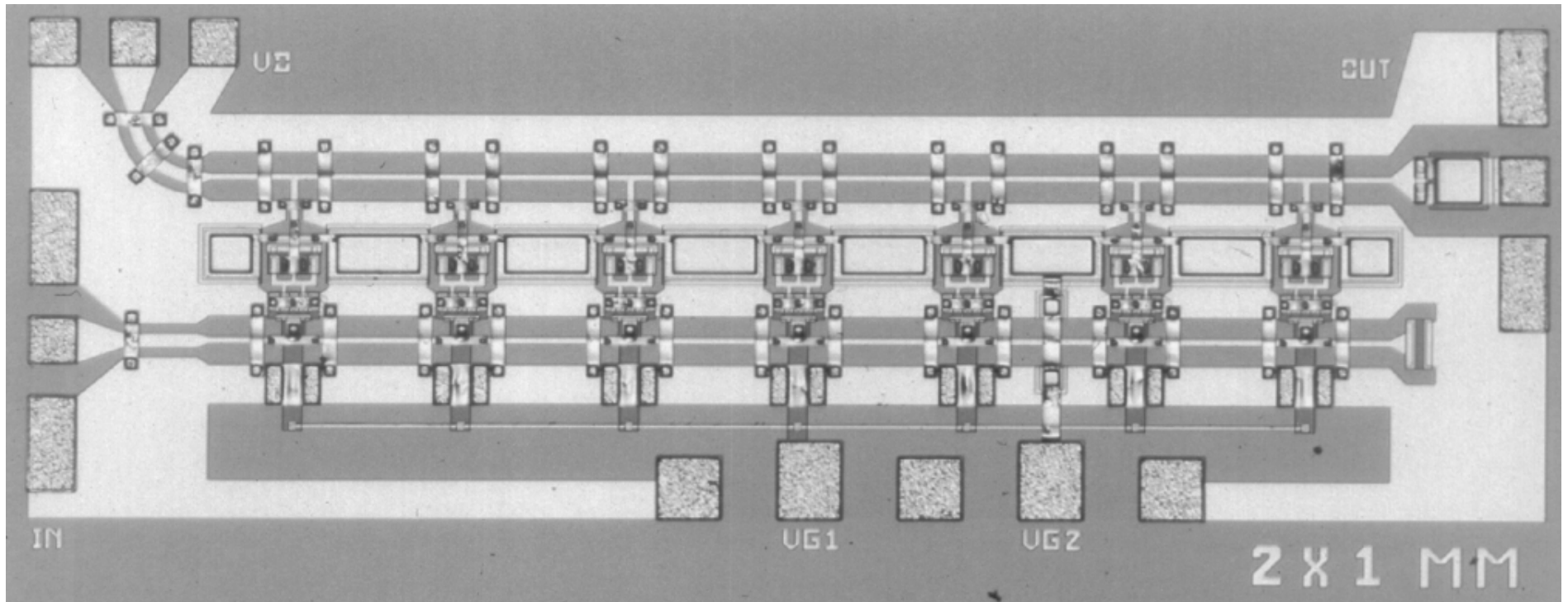
Regular, periodic structure:

- element values from design equations
- not computer optimized
- all cells have same FET sizes, same line lengths

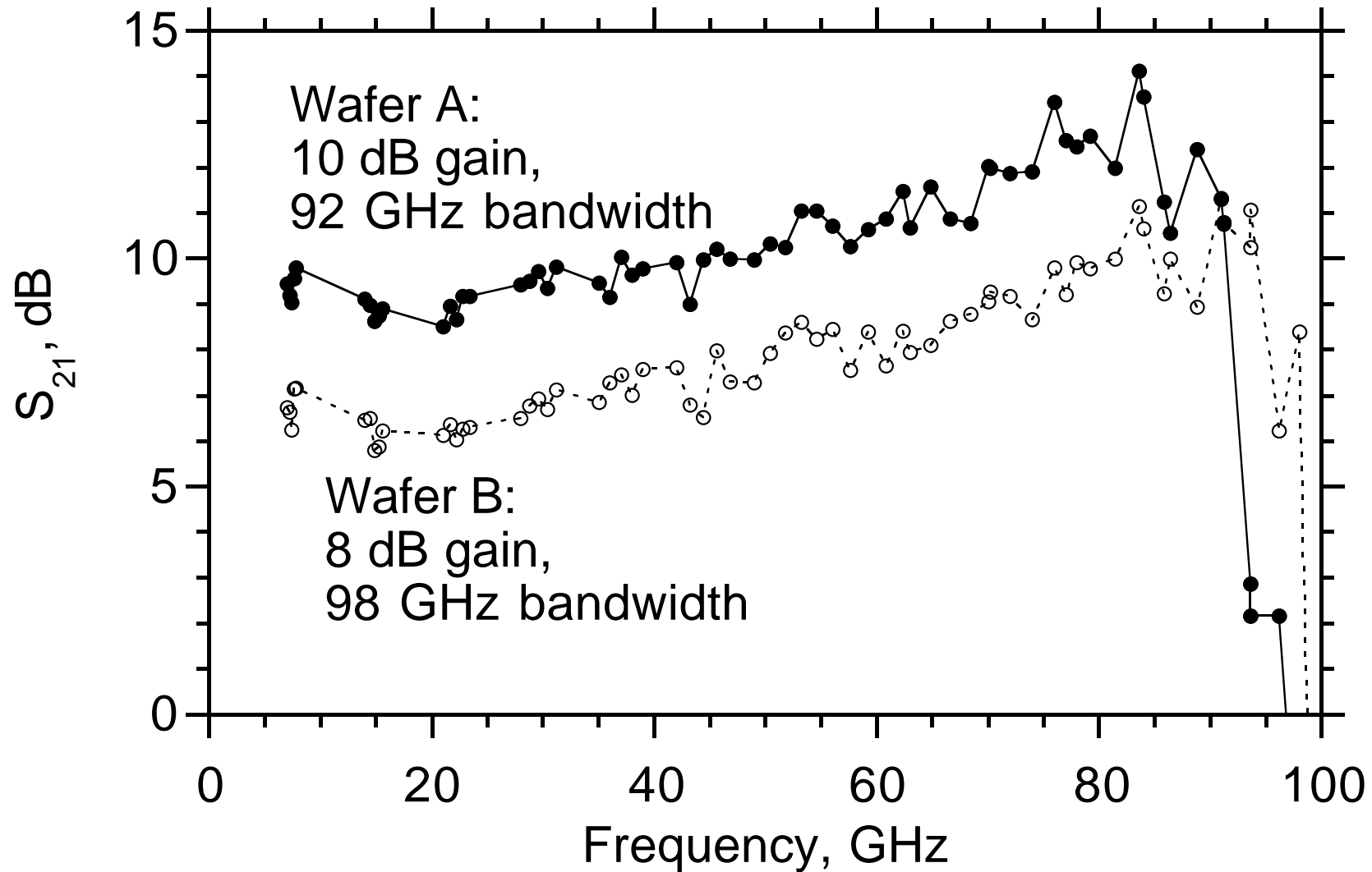
Conservative design:

- 2:1 capacitive division ratio
- designed for positive gain slope vs. frequency
- design gain-bandwidth well below MAG limit
- common-gate damping resistors: stabilization

# Die Photo

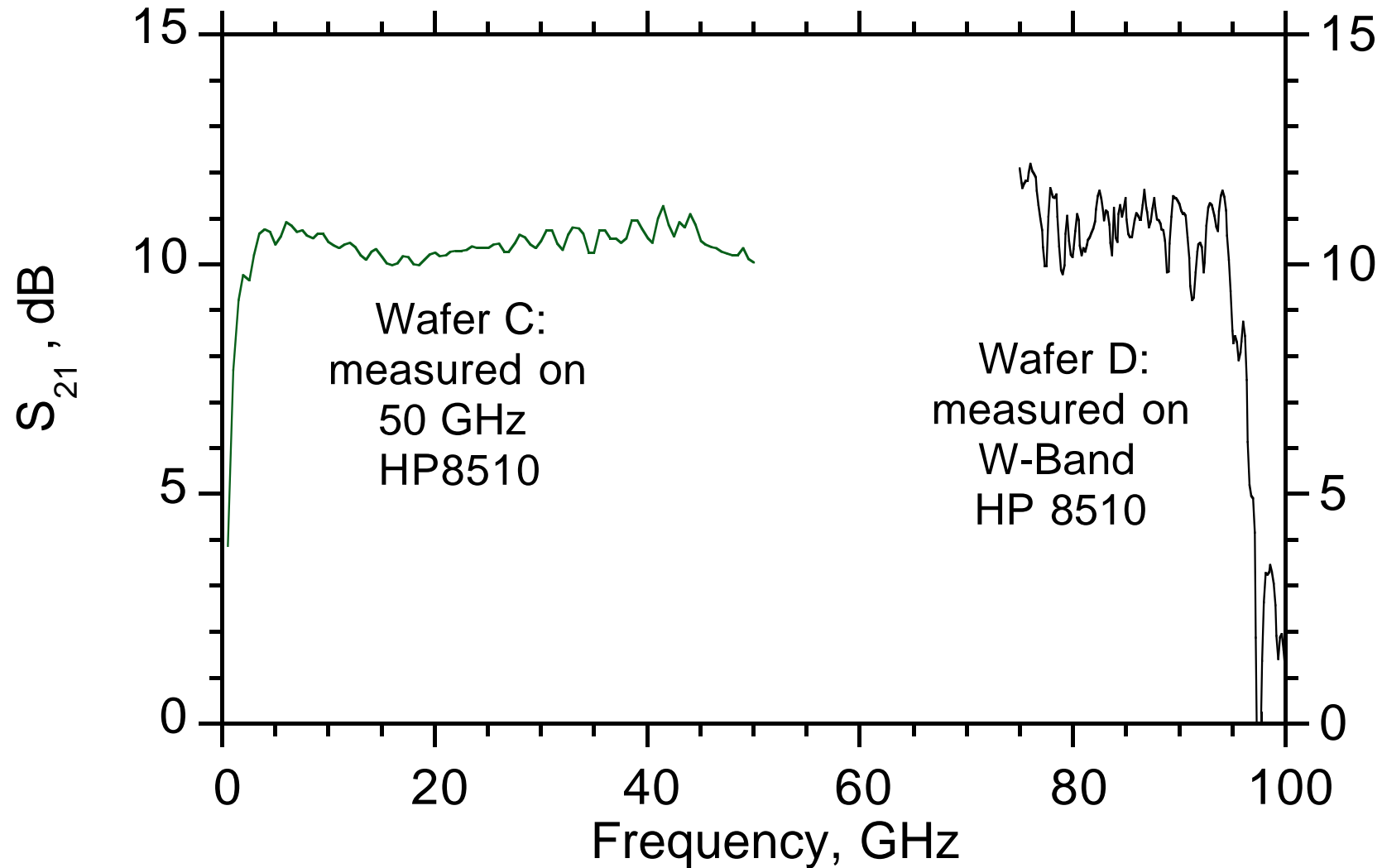


# Measured Results: InP Capacitive-Division TWA



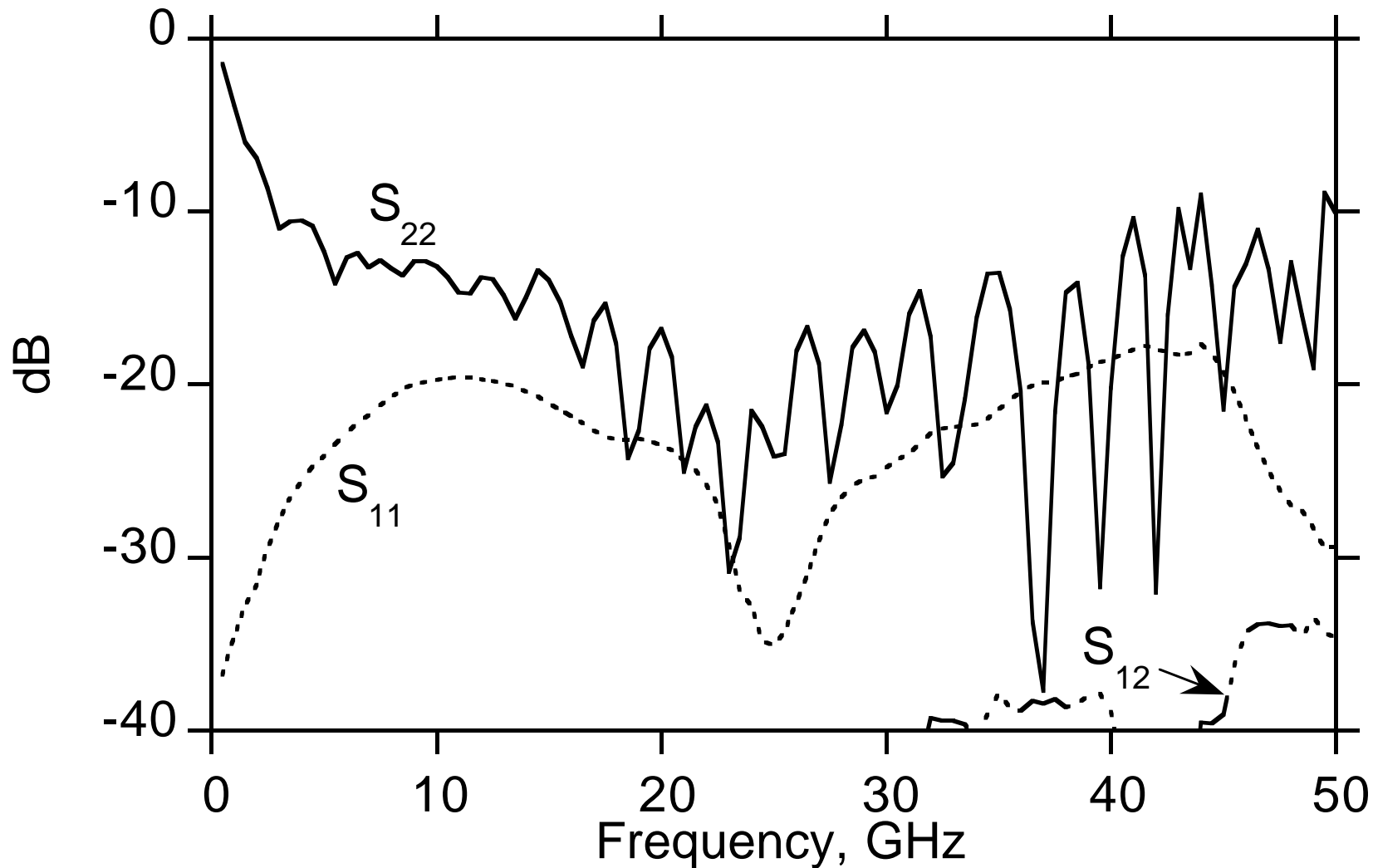
- Measured by UCSB 200 GHz on-wafer network analyzer
- Difference due to variation in  $C_{gs}$  &  $g_m$

# Measured Results: InP Capacitive-Division TWA



- 11 dB gain, 96 GHz bandwidth
- 340 GHz gain-bandwidth product

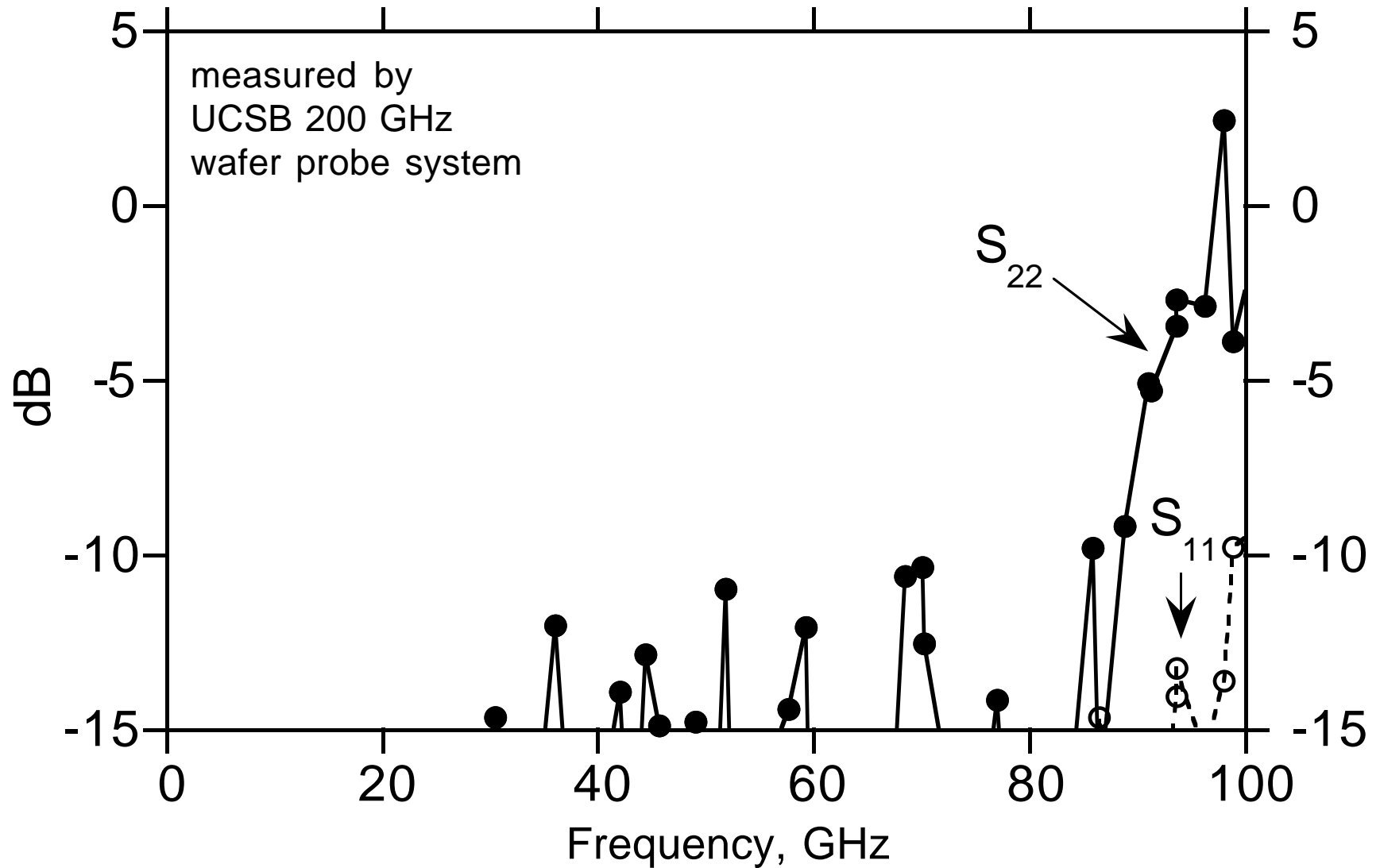
# DC-50 GHz Return Losses & Reverse Isolation



- $S_{22}$  resonances due to test configuration (bias probe)
- Good input and output return losses



# 7-100 GHz Return Losses & Reverse Isolation



- $S_{12}$  better than  $-15$  dB below 100 GHz

# Capacitive-Division TWA with 340 GHz Gain-Bandwidth Product

- Traveling-wave amplifier: broadband gain block
- Ayasli, 1988: capacitive division TWA
- Capacitive division can sizably improve gain-bandwidth product
- Results for InGaAs/InAlAs amplifier:  
11dB gain, 96 GHz bandwidth  
record 340 GHz gain-bandwidth product
- This work:  
conservative design  
results below limits of device technology
- Designs with 150 & 200 GHz target bandwidths  
currently in fabrication.